

Nonlinear Control of MEMS: Modeling, Analysis and Design

Quanyan Zhu, *IEEE Member*

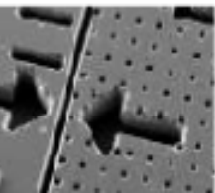
Software for Analysis and Design

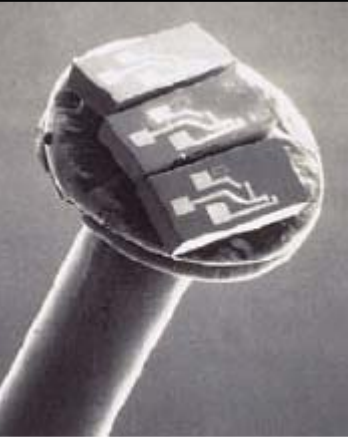
**Department of Electrical and Computer Engineering
Faculty of Engineering**

**McGill University
Montreal, Canada**

Presentation details on <http://www.ece.mcgill.ca/~qzhu4>

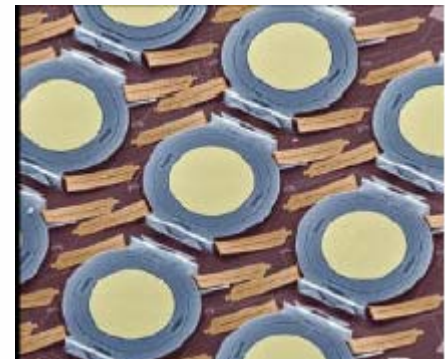
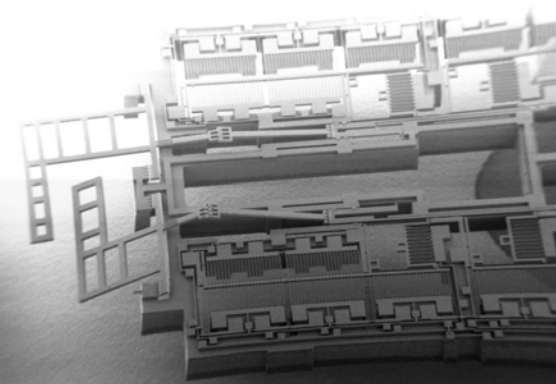
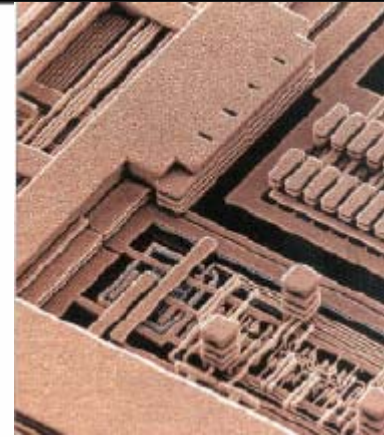
Contact: qzhu4@ieee.org or qzhu4@ece.mcgill.ca



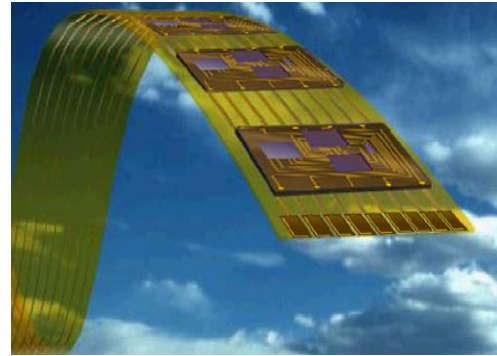
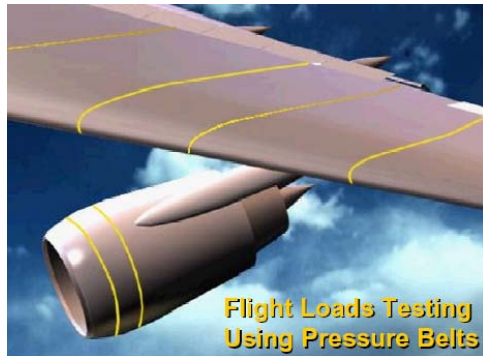


Outline

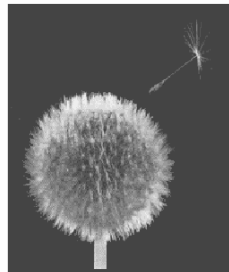
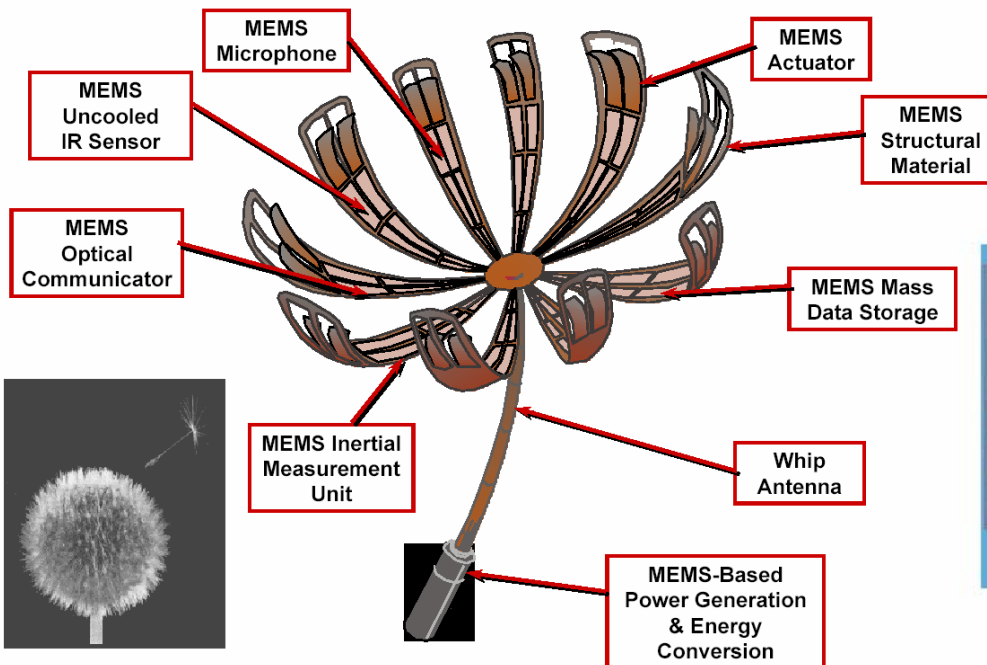
1. Introduction
2. Modeling and Analysis
3. Finite Element Analysis
4. Issues of Control
5. Future Work
6. Conclusion



MEMS: Micro-Electro-Mechanical Systems



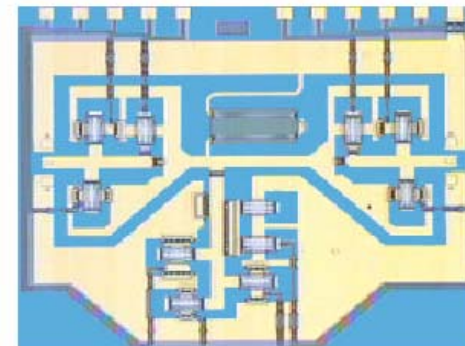
Boeing Pressure Belt using MEMS



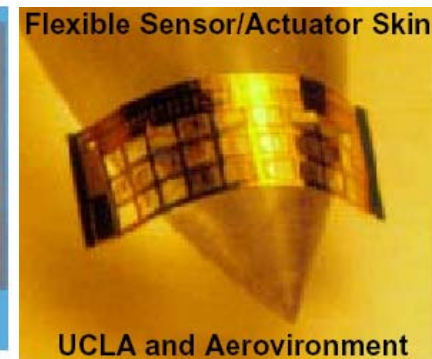
airborne surveillance dust

Wide Applications:

- Signal Processing
- Biomimetic Sensors
- Mass Data Storage
- Integrated micro-optomechanical components
- Embedded sensors
- Integrated RF Circuit, etc.

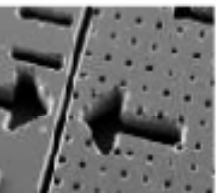
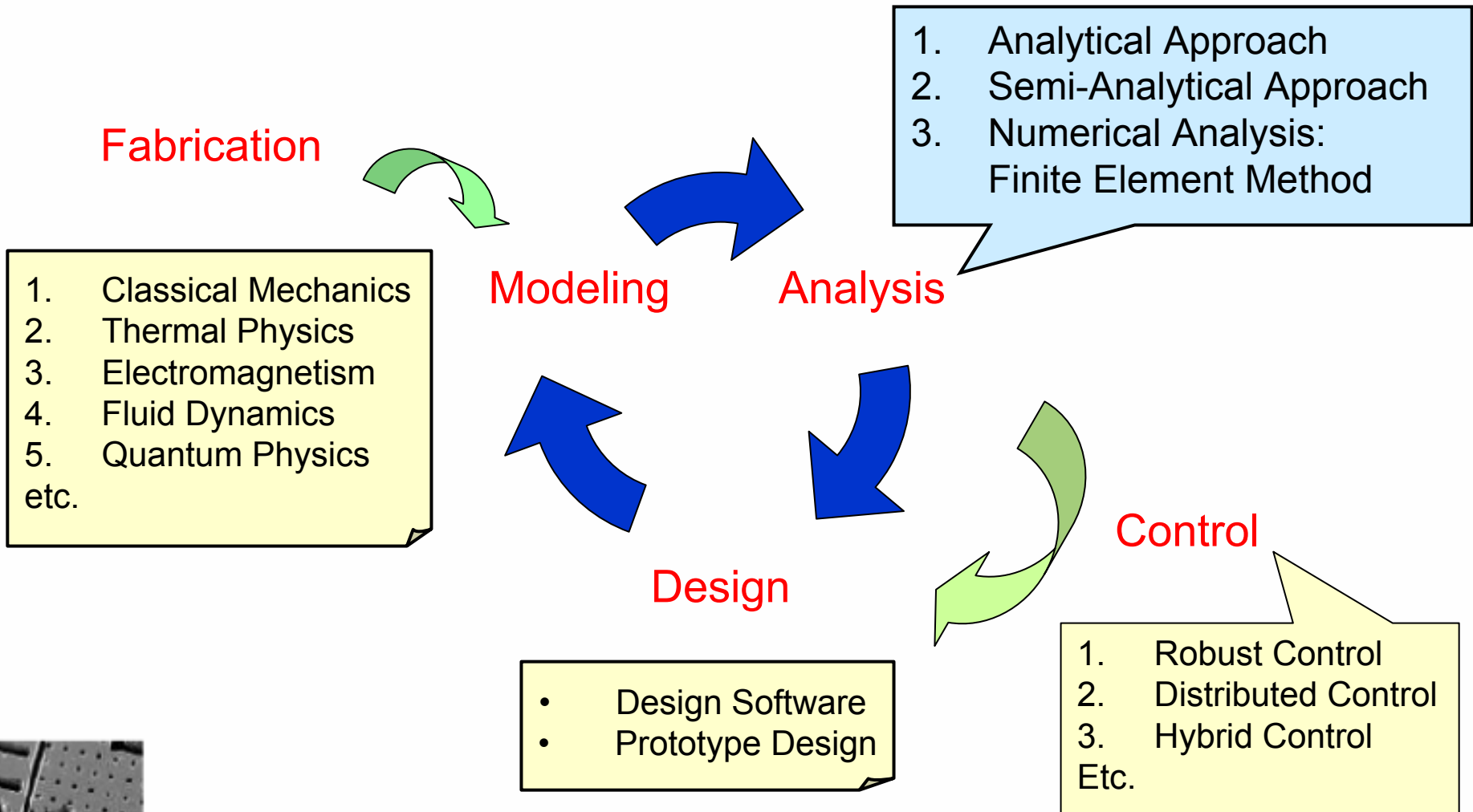


MEMS RF Tunable Filter

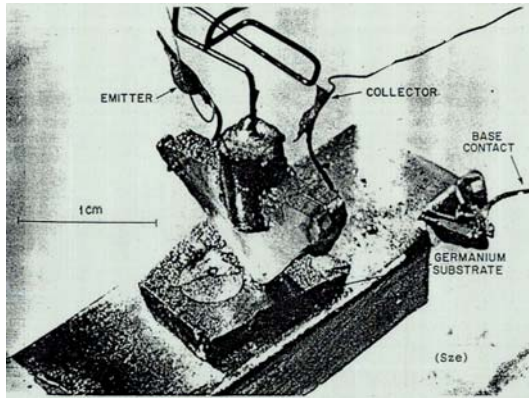


Sensor/Actuator

Introduction



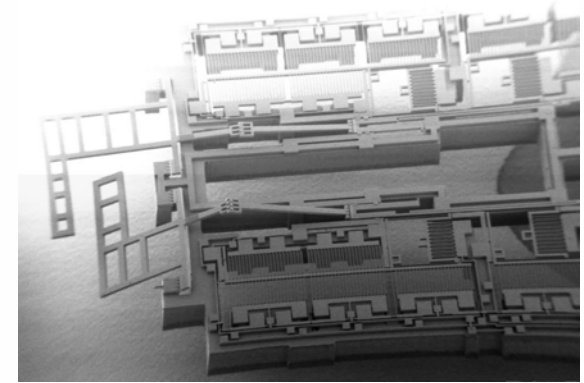
MEMS Fabrication



J. Bardeen, W.H. Brattain, "The first transistor, a semiconductor triode", Phys. Rev., 74, 230 (1948).



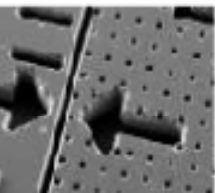
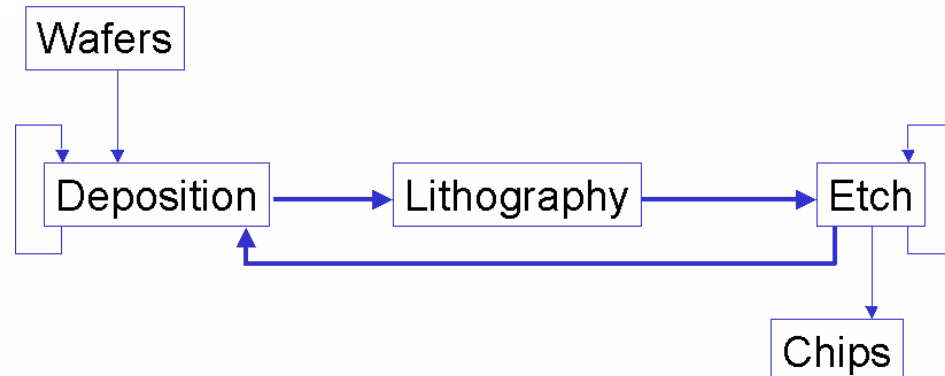
- Bulk micromachining
- Surface micromachining
- Go beyond microelectronics fabrication



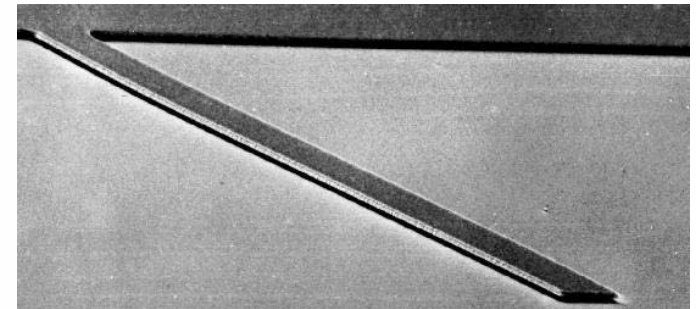
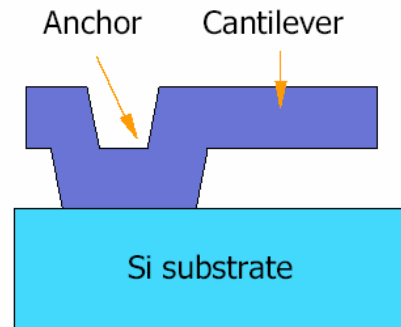
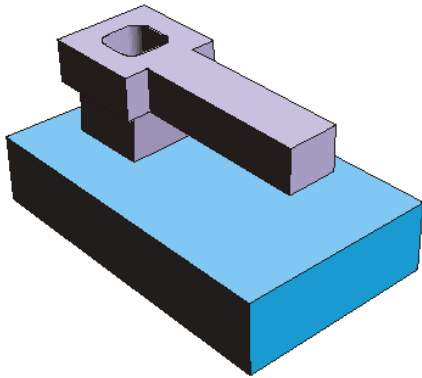
Microfabrication lab, Berkeley



Fundamental Fabrication Procedures



Fundamental Structures: Beam

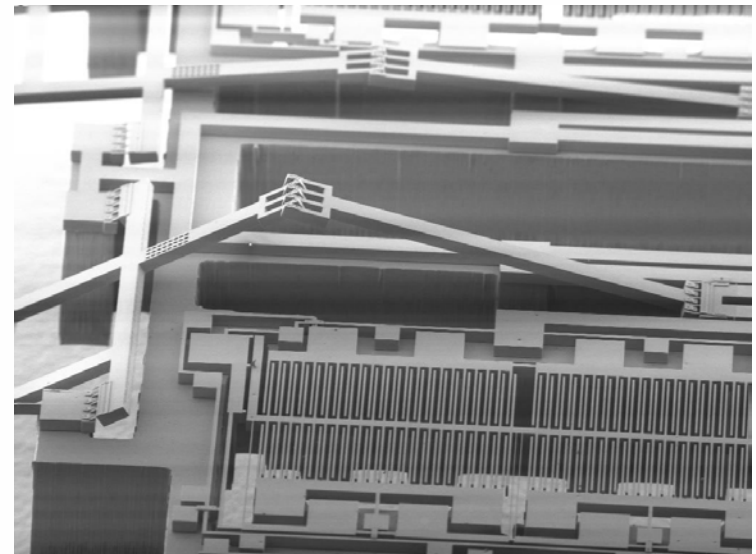


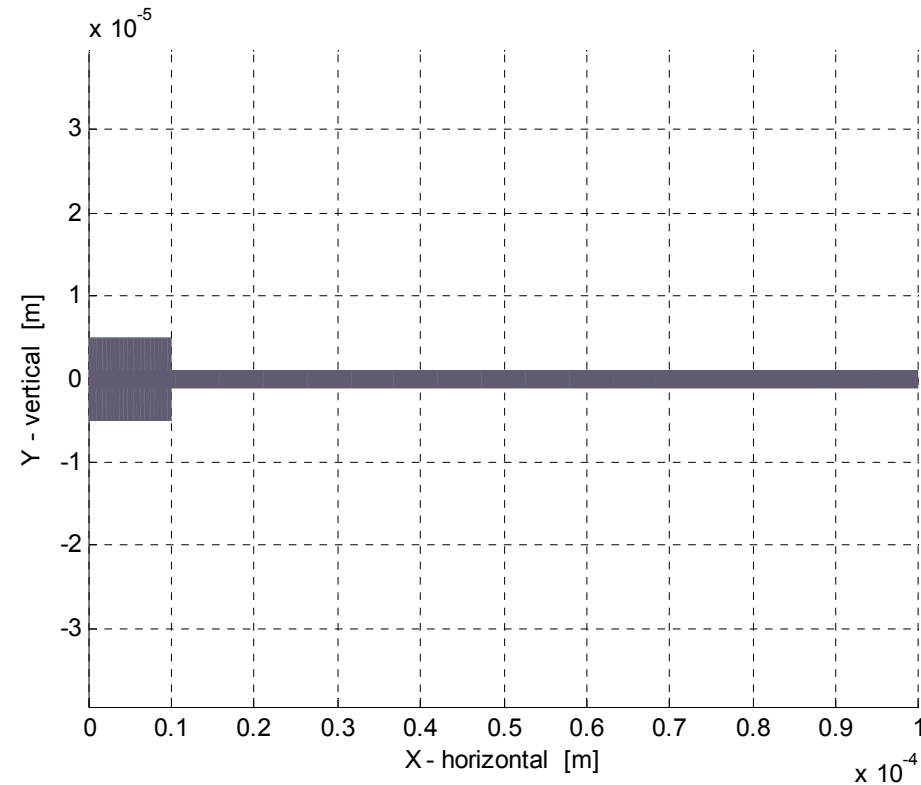
Cantilever-based devices:

- **Versatile** for a variety of applications
- Fabrication **simplicity**
- Better **Sensitivity**

Governing equation:

$$\rho A \frac{\partial^2 u}{\partial t^2} - \mu \frac{\partial^2 u}{\partial x^2} + \frac{\partial^2}{\partial x^2} \left(EI \frac{\partial^2 u}{\partial x^2} \right) = f(x, t)$$





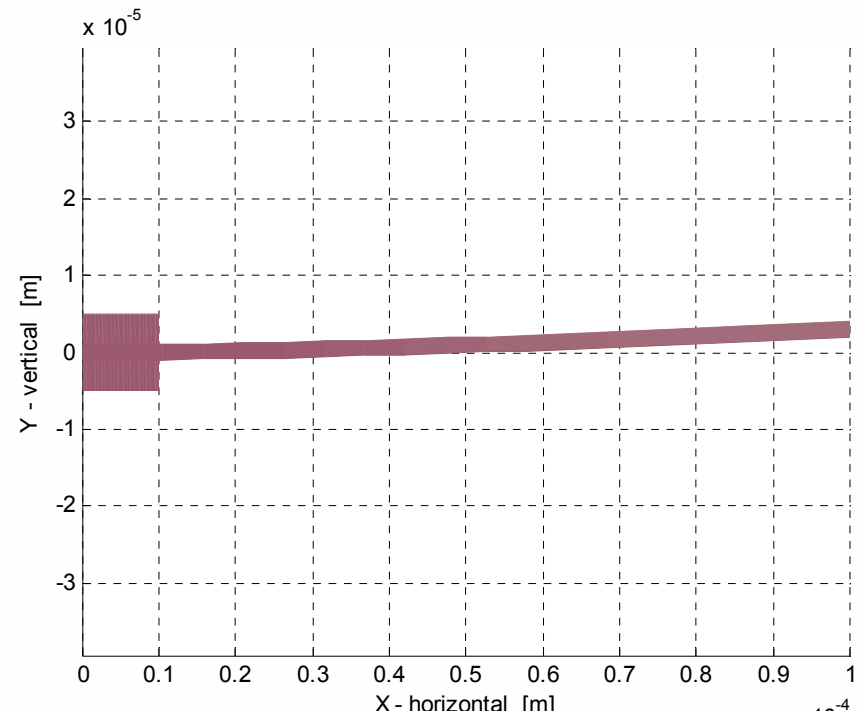
2 μ N on the tip produces a
displacement of 3.0 μ m

$E=165$ GPa

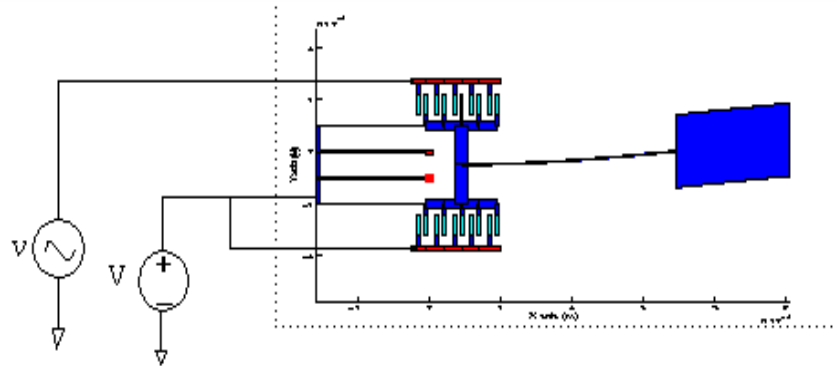
Material: Polysilicon

How about Coupling?

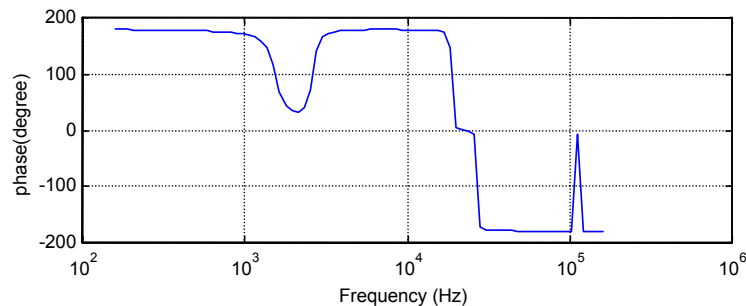
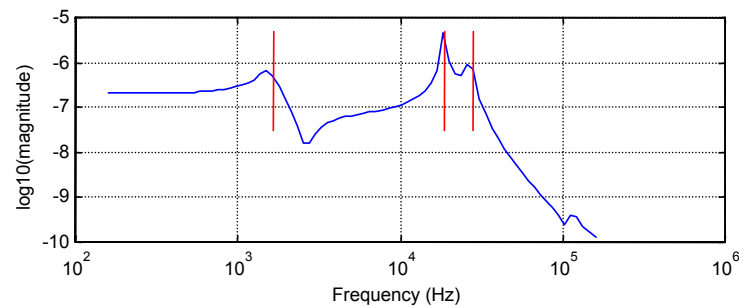
- Electro-elastic problem
- Thermo-elastic problem
- Thermo-magnetic problem, etc



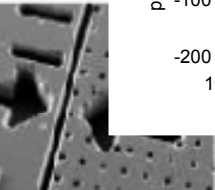
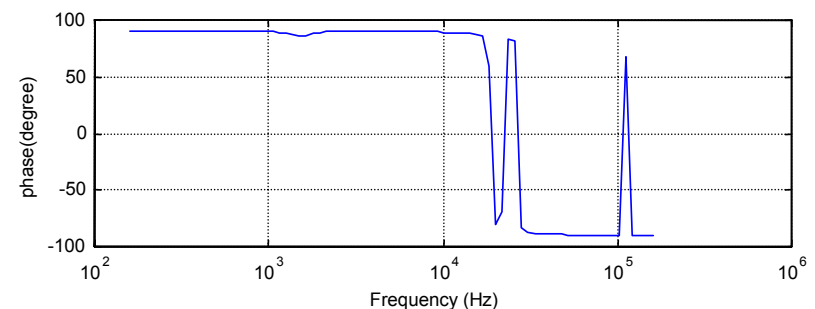
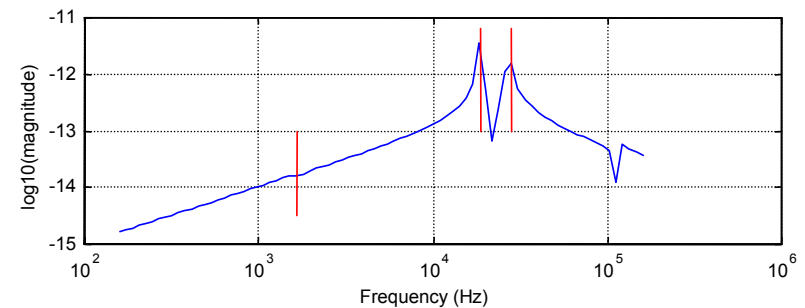
Simulation of a Linear Multiple Mode Resonator



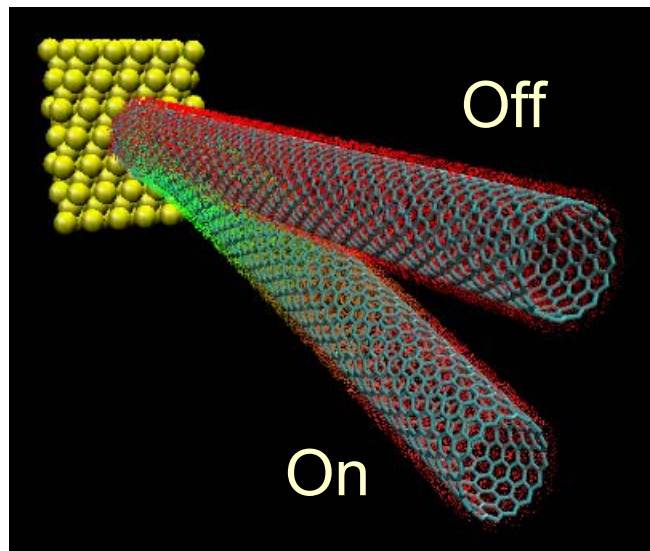
The response of vertical displacement of mass



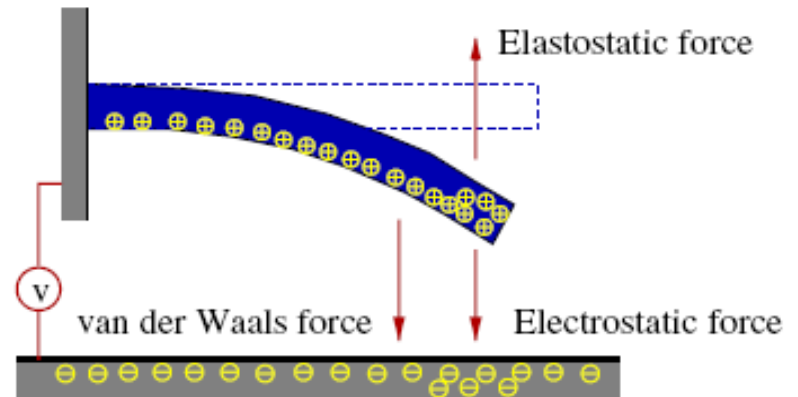
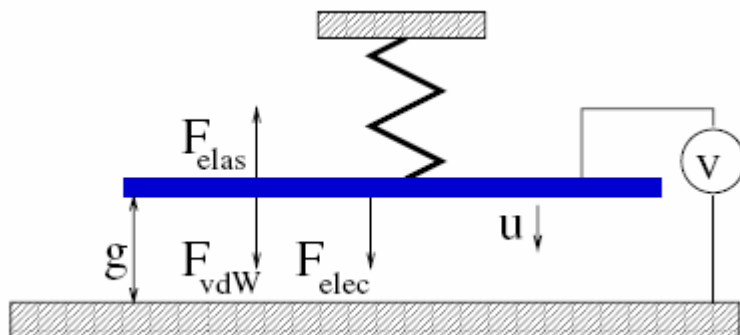
The response of induced current in lower comb



From MEMS to NEMS



SWNT Cantilever



Van der Waals Force per unit length:

$$q_{vdW} = \frac{d(E_{vdW} / L)}{dr}$$

where

$$E_{vdW}(r) = \iint_{V_1, V_2} \frac{n_1 n_2 C_6}{r^6(V_1, V_2)} dV_1 dV_2$$

Simple Model of Electro-mechanical Coupling problem

1-D Governing equation

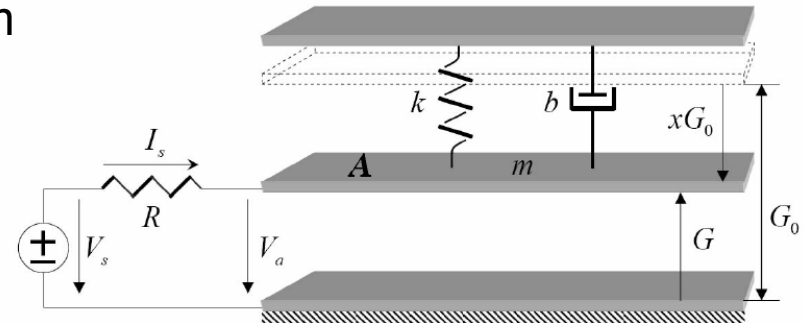
Mechanical:

$$m\ddot{x}(t) + b\dot{x}(t) + k(G(t) - G_0) = -\frac{Q^2(t)}{2\epsilon A}$$

Coupled term

Electrical:

$$\dot{Q}(t) = \frac{1}{R}(V_s(t) - \frac{Q(t)G(t)}{\epsilon A})$$



Coupled, Nonlinear, Second-order set of Equations:

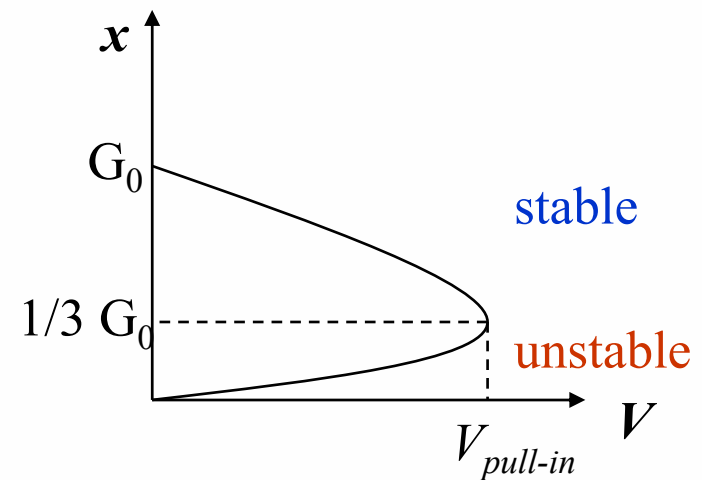
Potentially Unstable beyond a critical point: **pull-in Voltage**

$$\begin{bmatrix} \dot{x} \\ \dot{v} \\ \dot{q} \end{bmatrix} = \begin{bmatrix} v \\ -2\zeta v - x + \frac{1}{3}q^2 \\ -\frac{1}{r}q(1-x) \end{bmatrix} + \begin{bmatrix} 0 \\ 0 \\ \frac{2}{3r} \end{bmatrix} u$$

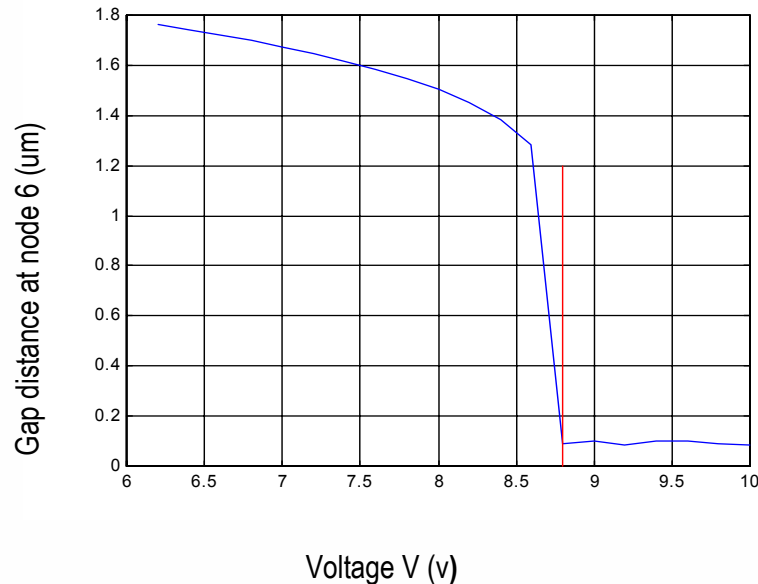
Normalized State-Space form of the dynamics
Some Nonlinear Control Scheme Might be Necessary!

1-D Simplified Analytical Solution

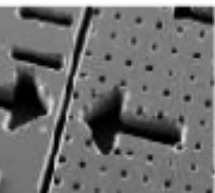
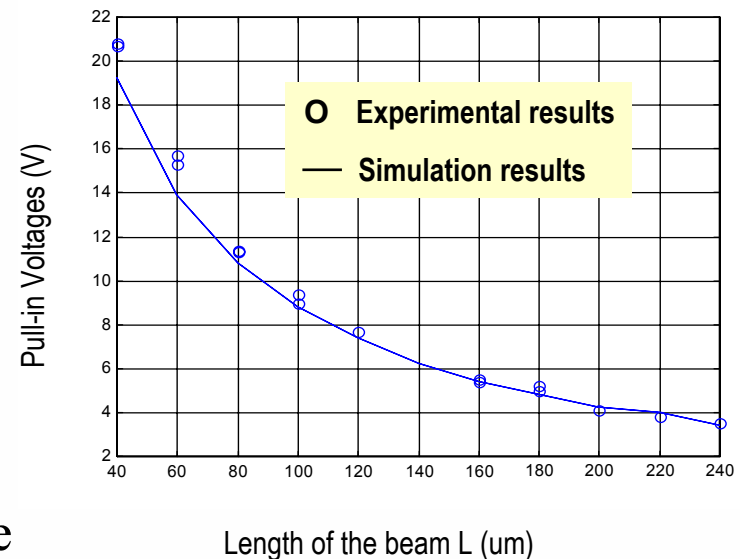
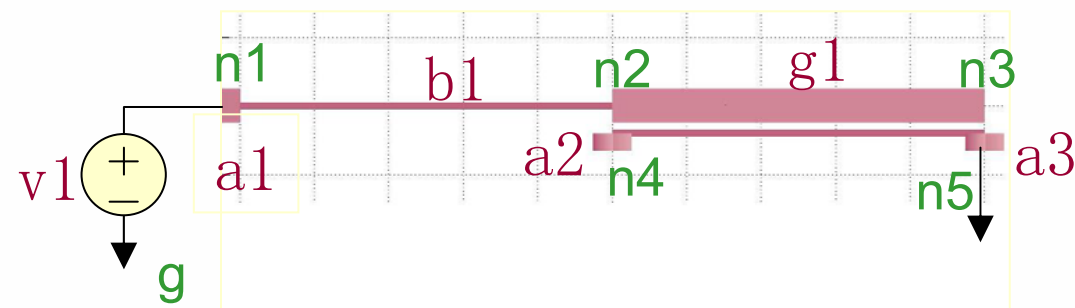
$$F = \frac{\epsilon_0 V^2}{2(s_0 - x)^2} = kx \quad \Rightarrow \quad V_{pull-in} = \sqrt{\frac{8kG_0^3}{27A\epsilon_0}}$$



Simulation of Simplified Model

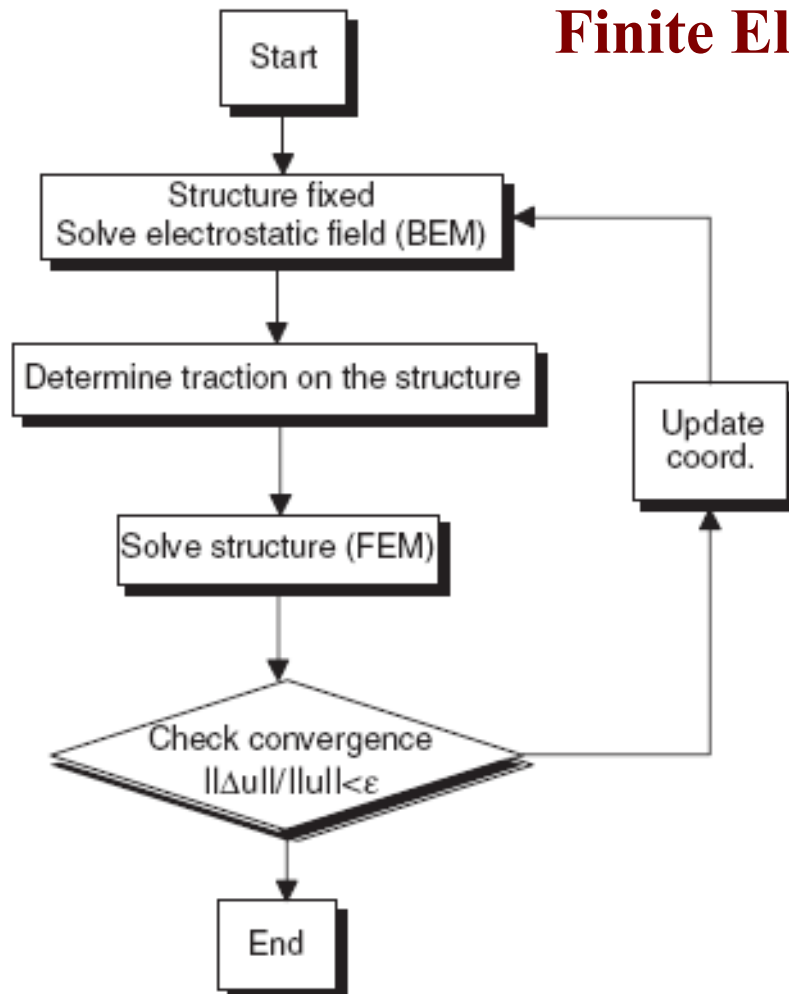


- Beam: Nominal $L_b=100\mu\text{m}$, $w=2\mu\text{m}$, $h=2\mu\text{m}$.
Measured : $L=100\mu\text{m}$, $w=1.74\mu\text{m}$, $h=2.003\mu\text{m}$
(Error of 0.13%)
- Gap plate: $L_g=100\mu\text{m}$, $w=10\mu\text{m}$, $h=2.003\mu\text{m}$.
- Young's Modulus: assume 165GPa.
- Fringing Effects Considered
- Pull-in Voltage Predicted at 8.56V



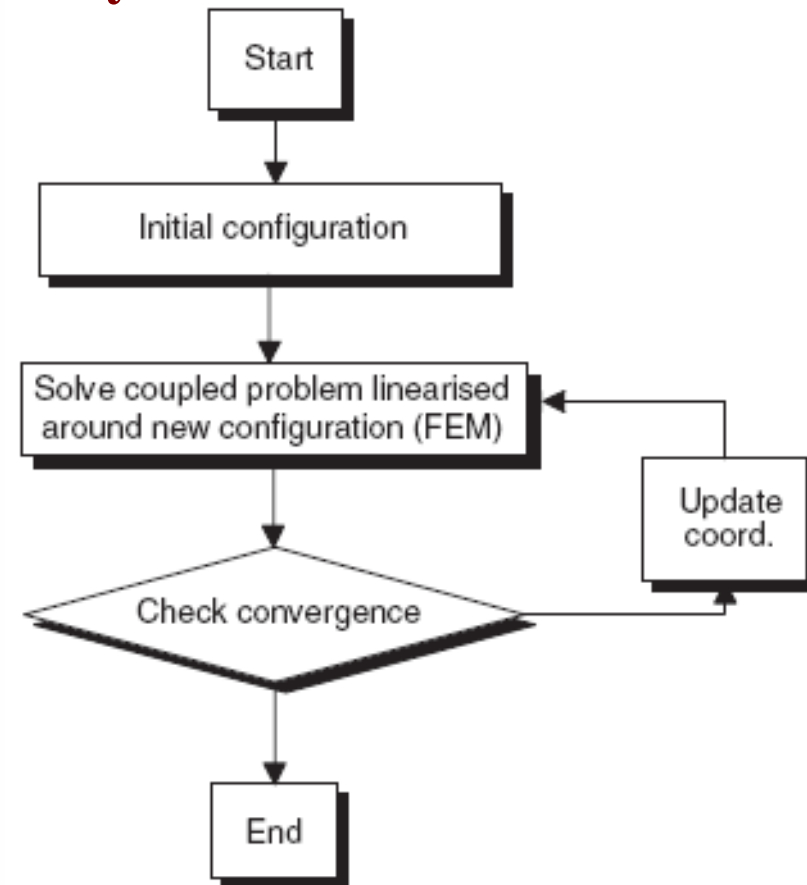
How to make this prediction more precise to include fringing effects, beam nonlinearity, and manufacturing error?

Finite Element Analysis



Conventional Weak coupling procedure:

Iterative Finite Element Analysis in separate solves for different physics domain



Strong Coupling procedure:

Simultaneous analysis in one solver

Finite Element Analysis (Cont'd)

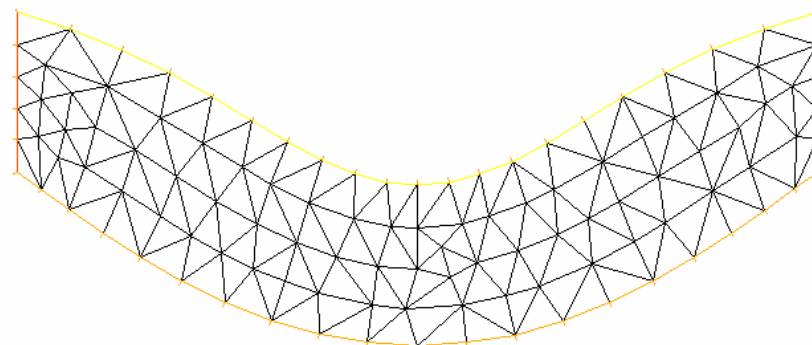
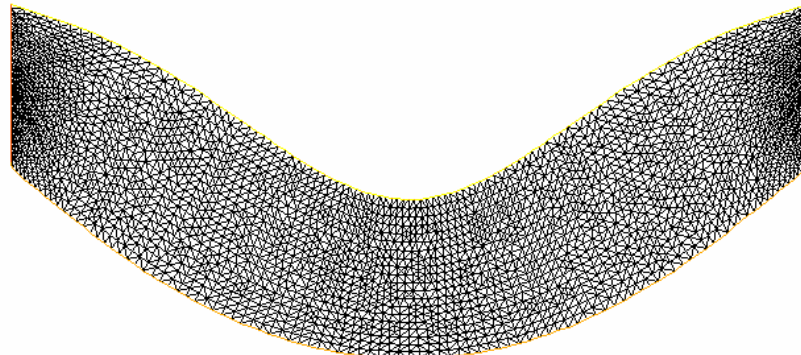
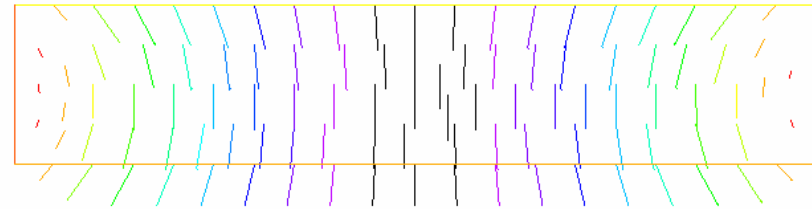
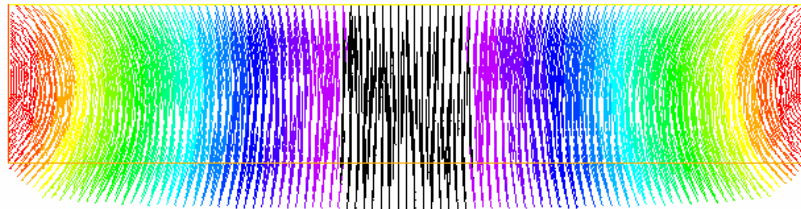
Discretization of Element:

$$\hat{\mathbf{u}}(x, y) = \sum_i \beta_{U_i}(x, y) U_i = \boldsymbol{\beta}_U \mathbf{U}$$

$$\hat{\phi}(x, y) = \sum_i \beta_{\Phi_i}(x, y) \Phi_i = \boldsymbol{\beta}_\Phi \boldsymbol{\Phi}$$

Monolithic Formulation:

$$\begin{pmatrix} \mathbf{K}_{UU} + \mathbf{K}_{UU}^* & \mathbf{K}_{\Phi U} \\ \mathbf{K}_{U\Phi} & \mathbf{K}_{\Phi\Phi} \end{pmatrix} \begin{pmatrix} \delta \mathbf{U} \\ \delta \boldsymbol{\Phi} \end{pmatrix} = \begin{pmatrix} \Delta \mathbf{F}_{\text{ext}} \\ \Delta \mathbf{Q}_{\text{ext}} \end{pmatrix}$$



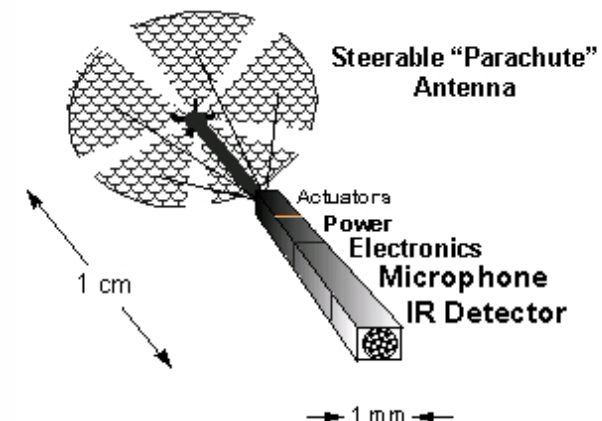
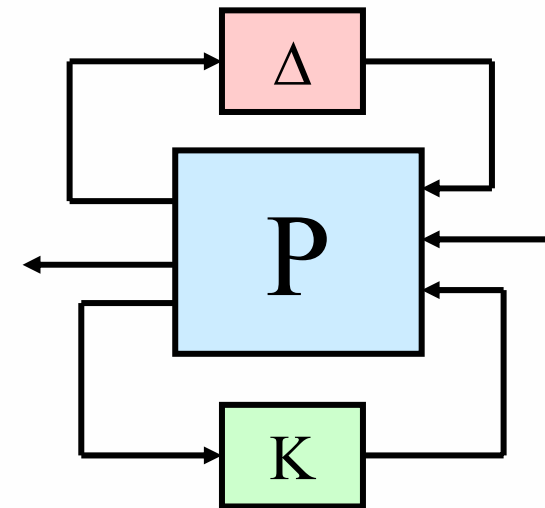
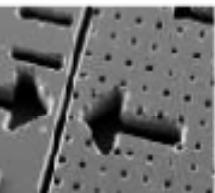
MEMS Control Challenges

- Single Device Stability
 - Nonlinearity from the device
 - Ensure the device operate in stability
 - Manage the manufacture **uncertainty** and chaotic behavior

Multi-variable Robust Control

- Increasing **Complexity** of Device
 - Conventional model-based optimization process **sensitive** to modeling errors.
 - Learning-based approaches, such as neural network: **hard to know the model**.
 - Both model-based and learning-based

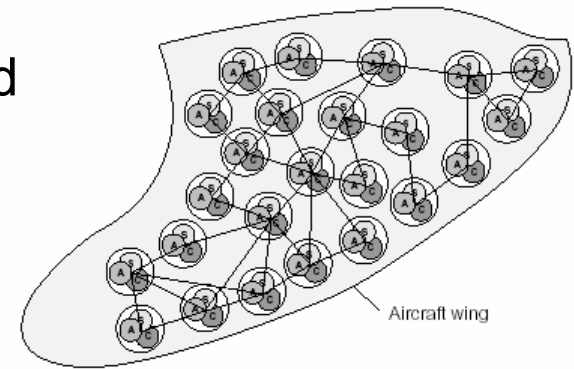
Model-based Neural Networks Control



MEMS Control Challenges (Cont'd)

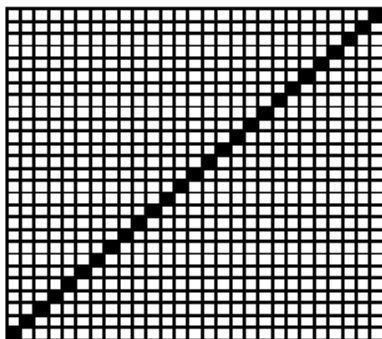
- **Multi-device System Stability**

- Distributed nature of MEMS: many embedded sensors and actuators interaction
- Need robust coordination: many elements can exhibit failures, delays and limited modeling ability in stochastic environment

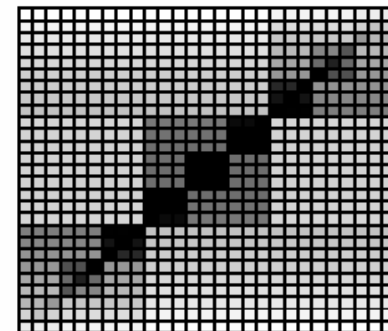


Distributed Market-based Control (Game Theoretically Based Control)

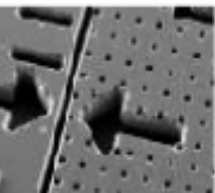
<http://ho.seas.ucla.edu>.



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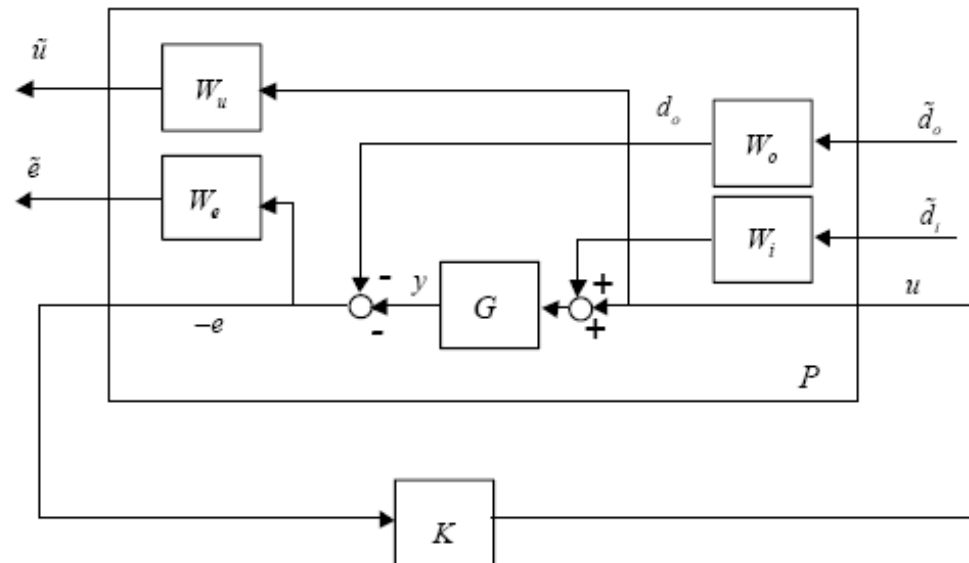
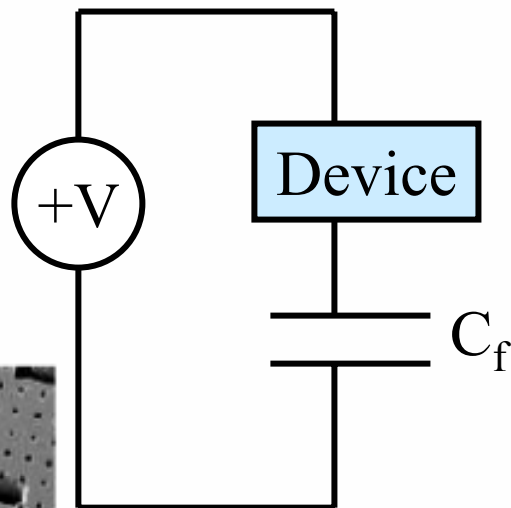


(hierarchy)



Multivariable Robust Control

- Present Control Design of the parallel-plate micro-actuator
 - Simple feedback with a capacitor may stabilize the system
- Proposed Robust Control Design of the benchmark problem
 - Provide more feedback control perspective for more sophisticated control
 - Directly deal with state-space of a control system
 - Deal with parametric uncertainty arising from manufacturing process
- Strong coupled finite element analysis for parameter identification



Conclusion

- Study of MEMS involves the multidisciplinary study of multi-physics problems. Finite element analysis is a flexible tool for solving physical quantities.
- Different levels of control problem exist, both on device level and system-network level. Intelligent schemes such as market-based control and neural networks are worthy of investigation
- We will establish a link between finite element analysis and control design, which will be used for parameter identification
- **Some Prospective Future Work**
 - Other control scheme:
 - Hybrid system optimal control
 - Neural Network based control
 - Game-theoretically based control
 - Adaptive finite element scheme
 - Nano-beam structure

